Search Notes				
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/772,370	SEN ET AL.
Examiner	Art Unit
CUONG H. NGUYEN	3661

SEARCHED					
Class	Subclass	Date	Examine		
701	96,110	12/3/2007	CHN		
<b>1</b>	93				
180	179	<b>V</b>	1		
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INT	INTERFERENCE SEARCHED				
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701	96,110 93	12/3/2007		CHN	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
WEST/DERWENT frwrd/bkwrd searches on closest refs. and allowable subject matter	12/3/2007	сни	
PG PUBS			
Inventors'names search			
IEEE Xplore	1		
		Y	